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Citation: CHEN, Y. ... et al, 2015. Characterization and application of aggregated porous copper oxide flakes for cupric source of copper electrodeposition. Materials Letters, 139, pp. 458 - 461.

Additional Information:

- This paper was accepted for publication in the journal Materials Letters and the definitive published version is available at http://dx.doi.org/10.1016/j.matlet.2014.10.080.

Metadata Record: [https://dspace.lboro.ac.uk/2134/17465](https://dspace.lboro.ac.uk/2134/17465)

Version: Accepted for publication

Publisher: © Elsevier

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Characterization and application of aggregated porous copper oxide flakes for cupric source of copper electrodeposition

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Abstract
Copper oxide was prepared with thermal decomposition of basic copper carbonate to complement the concentration of cupric ions for copper electrodeposition in a plating system with insoluble anode. Copper oxide particles with a structure of aggregated porous flakes had a wide size distribution ranging from 100 nm to 100 \(\mu\)m. Copper oxide exhibited a dissolution rate of about 15 s in 12.5 vol\% H\textsubscript{2}SO\textsubscript{4} with stable cupric concentration provided by rapid dissolution of copper oxide.

1. Introduction
Electronic products with the demand of miniaturization, multifunction and portability pursue high density interconnection (HDI) of printed circuit boards (PCB) for transmitting electrical signals in high speed \cite{1,2}. Copper electrodeposition has good agreement with HDI microvias metallization due to its void-free filling in the features, minimal topography of the final copper surface, and controllable impurity incorporation in the plated copper film \cite{3–5}.

Phosphorized copper anodic material was generally used to complement the cupric ions consumed in electrochemical reaction since it could avoid excessive polarization and prevent direct immersion of copper particles into reacting solution \cite{6}, compared with pure copper anodic material. However, impure chemicals in phosphorized copper, released during electroplating process could influence the structure of copper deposits \cite{7}. In addition, the change of size, topography and specific surface area of phosphorized copper during dissolved process could induce unstable current density and uneven distribution of electric fluxline, thereby resulting in weak plating uniformity of copper deposits \cite{2,8}. Alternatively, a novel plating system with insoluble anode is employed for copper electrodeposition with high performance, where copper oxide is dissolved for the complement of cupric ions. Microstructure of copper oxide plays a significant role in the dissolving speed in plating solution but sometimes the size, topography and specific surface area of copper oxide are strongly dependent on the preparation methods. Various methods were used to synthesize copper oxide with different morphology \cite{9}. In this work, copper oxide was prepared by thermal decomposition of solid-state basic copper carbonate in addition, copper oxide was employed for the complement of consuming cupric ions to form fine copper deposits during electrochemical deposition.

2. Experimental
CuSO\textsubscript{4} \(\times\) 5H\textsubscript{2}O (\(\geq\) 99.7 wt\%) was dissolved in pure water at 80 \(^\circ\)C and then filtered to further improve the level of purity. After adding polyethylene glycol (PEG) with an average molecular weight of 4000, NaHCO\textsubscript{3} was put into a vessel with CuSO\textsubscript{4} solution under the condition of vigorous stirring at the temperature of 70–80\(^\circ\)C. The stoichiometric ratio of CuSO\textsubscript{4} and NaHCO\textsubscript{3} was taken as 3:1. The concentration of PEG was 1 g/L. When CO\textsubscript{2} was completely released, the mixture solution was let to stand for 30 min to obtain the precipitation of basic copper carbonate. As-received basic copper carbonate was successively cleaned with ethyl alcohol and pure water for 3 times, then separated by centrifugation at 1000–2000 rpm for 15 min. Dry basic copper carbonate was put into a calciner for thermal decomposition at 500\(^\circ\)C for 3 h. A black copper-oxide powder product was finally obtained.

The feature micrographs of copper oxide particles were obtained using a scanning electron microscope (SEM). Size distribution of copper oxide particles in pure water was examined by laser particle...
size analyzer. The grain growth of copper oxide particles was monitored by X-ray diffraction spectra (XRD). Fourier-transform infrared (FT-IR) spectroscopy was used to determine chemical composition of copper oxide. 4.2 g copper oxide was added to 80 mL H₂SO₄ (12.5 vol%) to measure the dissolution rate using an AUfOlAB potentiostat (AUf85266) with a two-electrode cell. A copper wire with a diameter of 1 mm was used as the working electrode. A saturated mercurous sulfate electrode (SSE) was used as the reference electrode.

A plating system with insoluble anode was employed to form copper electrodeposition. The electrolyte for the electrochemical experiments contained 0.40 mol/L CuSO₄ · 5 H₂O and 1.80 mol/L H₂SO₄ in pure water with additives of 0.7 mg/L bis-(sodium sulfopropyl)-disulfide (SPS), 20 mg/L ethylene oxide-propylene

**Fig. 1.** SEM micrographs (a and b) and formation mechanism (c) of copper oxide and basic copper carbonate.
oxide co-polymer (EO/PO) and 60 ppm chloride ions. Copper oxide was used to retain the constant concentration of cupric ions in the plating solution. SEM and energy dispersive X-ray spectroscopy (EDS) were investigated to analyze the structure and composition of copper deposits.

3. Results and discussion

Copper oxide particles (Fig. 1a) exhibited nearly spherical appearance with aggregated porous flakes after the thermal decomposition of basic copper carbonate (Fig. 1b). During the formation of basic copper carbonate, PEG could act as a template direction agent to optimize growth orientation and growth rate [10,11]. OH\(^-\) groups preferentially absorbed ether groups in PEG solution moved towards the long chain of the PEG to form the crystal growth of basic copper carbonate with a flake-like structure [12]. However, the presence of PEG could also lower the reactivity of basic copper carbonate, resulting from the hydrogen bonding strength between PEG and water for inhibiting the rapid movement of ions. On the other hand, the hydrophilic groups in the polymeric chain of PEG adsorbed at the surface of the crystal nuclei to prevent rapid growth of the particles. As basic copper carbonate grew mature, PEG and water molecules gradually departed from the particles which tended to form agglomerates in response to the minimum high surface energy [11,12]. Thus, aggregated basic copper carbonate flakes resulted in the emission of CO\(_2\) and water, thereby causing the porous structure and loose aggregation of the flakes.

Fig. 2a presented the size distribution of copper oxide particles. Aggregated copper oxide flakes had a wide size distribution ranging from 100 nm to 100 \(\mu\)m. Despite aggregation formation, small size copper oxide particles could also be measured since surrounding copper oxide flakes could escape from the surface of spherical aggregation. On the other hand, when copper oxide was immersed into pure water (polar solution), oxygen group of copper oxide could combine with hydrone to form hydrogen bonding, thereby inducing interaction force to make superficial copper oxide flakes disperse into the pure water.

All XRD peaks in Fig. 2b corresponded to the grain growth of copper oxide according to JCPDS (Joint Committee on Powder Diffraction Standards) card of copper oxide (JCPDS 48-1548). As-prepared copper oxide was preferentially [1 1−1] and [1 1 1] textured with stronger intensity. Fig. 2c displayed the FTIR spectrum of copper oxide particles. Copper oxide with Cu−O stretching vibrations exhibited characteristic absorption bands at 479 cm\(^-1\) and 542 cm\(^-1\) [13]. The absorption at 3445 cm\(^-1\) indicated the presence of hydroxide group due to water absorption at the surface of copper oxide while the absorption peak at around 1624 cm\(^-1\) corresponded to O−H bending vibrations combined with copper atoms. Thus, the formation of copper oxide compound was confirmed. XRD and FTIR indicated that as-prepared copper oxide could meet the requirement of high purity.

As shown in Fig. 3, potential of 12.5 vol% H\(_2\)SO\(_4\) solution was stable at −0.510 V before adding as-prepared copper oxide. However, potential jumped to −0.437 V in 2 s with the addition of copper oxide in the solution. Thereafter, potential of mixture solution increased slowly and finally reached a stable value of −0.390 V at 16.9 s. In addition, the color of mixture solution changed from black to blue due to the dissolution of copper oxide.

![Fig. 2. Size distribution (a), XRD patterns (b) and FTIR spectrum (c) of copper oxide.](image)

![Fig. 3. Potential transient with the addition of copper oxide particles to 12.5 vol% H\(_2\)SO\(_4\); inset shows the color change of the solution.](image)
chance with H⁺. Therefore, aggregated and porous structure in copper oxide could form a synergistic effect to improve the dissolving reaction in 15 s.

Fig. 4a and b displayed surface micrographs of copper deposits from the electrolytes with different cupric concentrations but with the same concentrations of additives as 0.7 mg/L SPS, 20 mg/L EO/PO and 60 ppm chloride ions. Copper growth could be influenced during industrial copper electrodeposition if cupric ions were not rapidly complemented in a plating system with insoluble anode. As shown in Fig. 4b, copper deposits exhibited local aggregation of copper particles and surface voids of copper deposition were produced to induce large resistance when the cupric concentration decreased to 0.3 mol/L. Therefore, as-prepared copper oxide particles were added into the electrolyte to lead the cupric concentration to increase to 0.4 mol/L and keep it stable during copper electrodeposition. In this way, copper deposits had good surface morphology with well-distributed even copper particles, as shown in Fig. 4a. EDS of Fig. 4c presented that copper deposits exhibited high purity when as-prepared copper oxide particles were used to complement the cupric ions for electrodeposition.

4. Conclusions

Copper oxide was prepared by the thermal decomposition of aggregated basic copper carbonate flakes that were formed using PEG as a template. Aggregated copper oxide had a wide size distribution ranging from 100 nm to 100 μm. As-prepared copper oxide exhibited high purity and a rapid dissolution rate so that it could rapidly complement the cupric concentration in the electrolyte for fine copper growth during electrodeposition.

Acknowledgments

The authors gratefully acknowledge the support of Guangdong Innovative Research Team Program (No. 201301C0105324342), National Natural Science Foundation of China (No. 61474019) and Ph.D. Programs Foundation of Ministry of Education of China (No. 20120185100021), and we also express our sincere thanks to the support of China Scholarship Council (No. 201306070032).

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